


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/725,674	HIRANO ET AL.	
	Examiner	Art Unit	
	Minh Dieu Nguyen	2137	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
713	176				705	51				
INTERNATIONAL CLASSIFICATION					713	201				
H	0	4	L	9/00						
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<i>Nguyen Minh Dieu</i> 6/10/05 (Assistant Examiner) (Date)	<i>Andrew Caldwell</i> ANDREW CALDWELL SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 6/10/05	Total Claims Allowed: 17 O.G. Print Claim(s) 1 O.G. Print Fig. 5
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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